

14. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFVN220		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1703080097-08.ZNF	Test Dates: 03/10/2017 - 03/13/2017	DUT Type: Portable Handset		Page 51 of 53

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Figure 14-1
Test Setup for Wireless Device

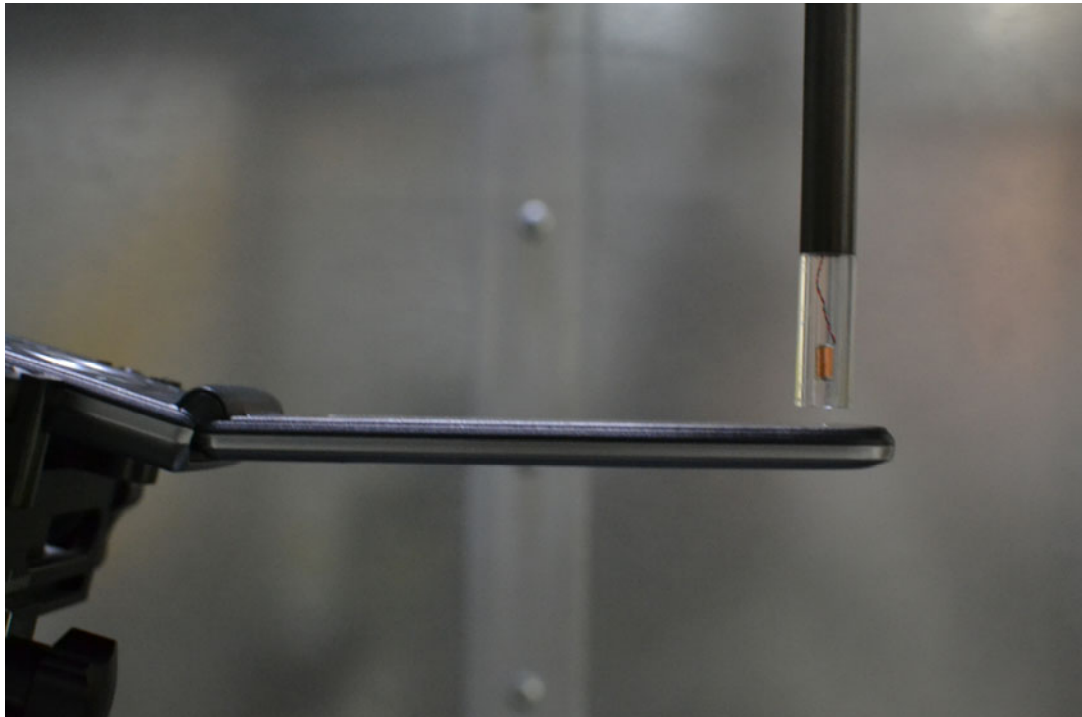


Figure 14-2
Test Setup for Wireless Device

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Figure 14-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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